

<p align="center"><b>Notice of References Cited</b></p>	Application/Control No. 10/721,384	Applicant(s)/Patent Under Reexamination TAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,265,771 B1	07-2001	Ference et al.	257/706
	B	US-5,705,851	01-1998	Mostafazadeh et al.	257/675
	C	US-6,724,071 B2	04-2004	Combs, Edward G.	257/666
	D	US-6,271,581 B2	08-2001	Huang et al.	257/666
	E	US-5,293,301	03-1994	Tanaka et al.	361/707
	F	US-5,311,060	05-1994	Rostoker et al.	257/796
	G	US-6,184,580 B1	02-2001	Lin, Shih-Hao	257/712
	H	US-6,559,525 B2	05-2003	Huang, Chien-Ping	257/675
	I	US-6,198,171 B1	03-2001	Huang et al.	257/787
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	61-49446	03-1986	Japan	Nose	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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